Applicant(s)/Patent Under Reexamination Application/Control No. 10/618,275 DEAN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Tan Le 3632 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,262,923	11-1993	Batta et al.	361/679.37
*	В	US-6,102,499	08-2000	Chen et al.	312/223.2
	O	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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